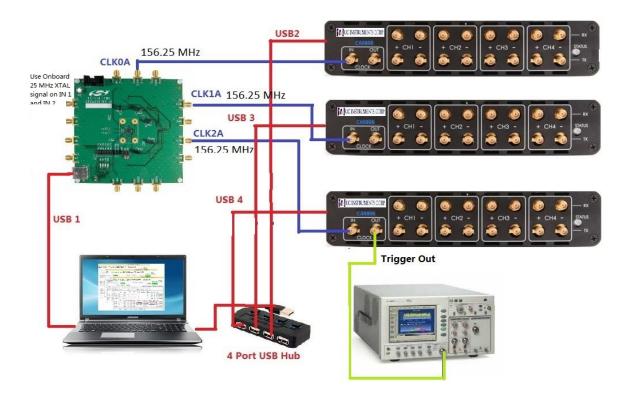
CA9806-12 12 Channels 1.0 ~ 17.0 Gb/s (200Gbps) Pulse Pattern Generator and Error Detector

Technical Specification V1.00

March., 2016





www.ucinstruments.com

CA9806-12 12 Channels 1.0 ~ 17.0 Gb/s(200 G) Pulse Pattern Generator and Error Detector

The UC INSTRUEMNTS CA9806-12 is a high performance, flexible 12 channels Pulse Pattern Generator and Error Detector that can operate from 1.0 to 17.0 Gb/s (200 G). It is combined with three sets CA9806 4 CH 1.0 to 17.0 Gbps Pulse Pattern Generator and Error Detector that incorporates an external one by 4 rate clock synthesizer. Its small size allows it to be placed close to the device under test, it can also be placed further away using the TX driver pre and post emphasis controls features to compensate for cable and interconnect losses. It also has a non destructive, integrated eye outline capture feature along with a quick eye height and width measurement capability. Build-in 8.5 ~ 15 Gb/s eye diagram testing function.

The CA9806-12 was designed to characterize high speed digital links during the engineering, manufacturing or installation phases of a project. It was special design for 12 CH $1.0 \sim 17$.0 Gbps transmitters and receivers devices testing. Such applications could include the testing of IC's, optical components, transceivers, copper cables, back planes and interconnects. The CA9806-12 can be used for

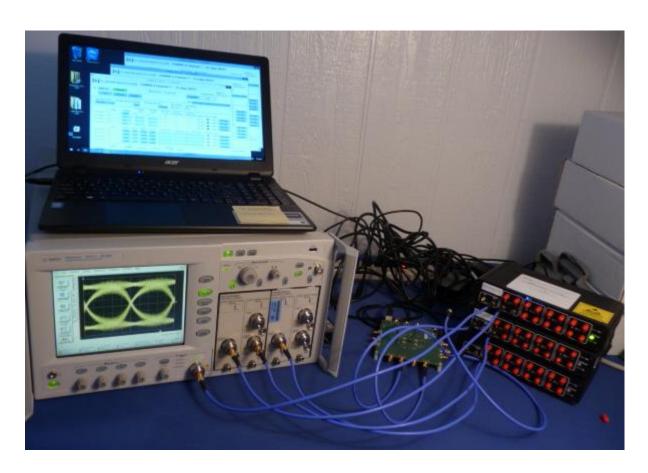
compliance testing of Ethernet, Fiber Channel, Infiniband, PCIE, SONET and proprietary link standards.

Features

- Total 12 CH 1.0 to 17.0 Gb/s pulse pattern generator;
- PRBS 2⁷-1, 2⁹-1, 2¹¹-1, 2¹⁵-1, 2²³-1, 2³¹-1, 2⁵⁸-1:
- Four channel NRZ PPG and ED;
- External clock synthesizer;
- Adjustable clock output;
- Typical JRMS of 1 ps and JPP of 7 ps;
- TX level from 25 mV to 1500 m V PPDIFF;
- Eye monitor from 8.5 to 15.0 Gbps operation;
- Pre and Post cursor emphasis;
- 64 bit programmable fixed pattern
- Pre-emphasis output signal functionality
- PPM offset control;
- Computer control via USB
- Cost effective solution for production;
- API command set
- Small footprint size of 216 mm x 51 mm x 127 mm

Applications

- Testing of optical transceiver modules (SFP+, XFP, X2, Xenpak, XPAK), transponders, linecards, and subsystems
- Testing of opto-electronic components and devices (TOSA, ROSA, lasers, etc...)
- Testing of Gb/s ICs, PCBs, electronic modules, subsystems, and systems
- Serial bus and high-speed backplane design
- Installation testing and troubleshooting in optical transport networks
- can be used forcompliance testing of Ethernet, Fiber Channel, Infiniband, PCIE, SONET and proprietary link standards
- It was special design for 12 CH 1.0 ~ 17 .0 Gbps transmitters and receivers devices testing.



CA9806-12 12 Channel 1.0 ~ 17.0 Gb/s (200G) Pulse Pattern Generator and Error Detector Testing System

Specification

Absolute Maximum Ratings	Symbol	Min.	Тур.	Max.	Unit	Notes
Storage Temperature	Ts	-20	_	70	°C	
AC Voltage Range	VAC	90	_	246	VAC	
AC Voltage Frequency Range	V_{FREQ}	47	_	63	Hz	
Data RF and Clock Voltage Output	Vout	-0.5	-	1.4	V	
Data RF Voltage Input	VinData	-0.5	-	1.8	V	
Clock In Voltage Input	VinClk	0	-	1.2	V	
USB Pin Voltage	VinUSB	-0.3	_	5.5	V	
RF and Clock ESD HBM	RFesdH	-1000	_	1000	V	
RF and Clock ESD CDM	RFesdC	-250	_	250	V	
RF, Clock and USB Latchup	VI	-100	_	100	mA	
USB ESD HBM	USBesdH	-2000	_	2000	V	
USB ESD CDM	USBesdC	-500	_	500	V	
Electrical Characteristics	Symbol	Min.	Тур.	Max.	Unit	Notes
Case Temperature	Tc	5	_	45	°C	
AC Supply Current	Icc	0.75	100	_	mA	
Baud Rate (NRZ format)	BR	1	15	17	Gb/s	(Note 1)
Baud Rate Setpoint Accuracy	BRa	-10	-	10	PPM	(Note 2)
Baud Rate PPM Offset	Bro	-999	_	999	PPM	1 PPM step size
Power On Initialization Time	Ton	_	_	15	Seconds	
Eye Phase Steps	ЕМр			64	Steps	2 pS per unit
						7.8 mV per
Eye Amplitude Steps	EMv	_	_	128	Steps	unit
Fixed Pattern Length	PL		ĺ	64	Bits	

Note 1: Contact Factory for higher and lower operation

Note 2: Aging, Temperature and Voltage

TX Electrical	Symbol	Min.	Тур.	Max.	Unit	Notes
CML Output (Single Ended)	VoutSE	0	-	750	mVpp	AC Coupled
CML Output (Differential)	VoutDIFF	0	-	1500	mVpp	AC Coupled
CML Output (Differential) Step						
Size	VoutSS	_	25	_	mVpp	
CML Output (Differential)						
Squelch	VoutSqu	0	_	30	mVpp	
CML Output (Rise/Fall Time)	tR, tF	20	-	_	ps	20-80%
Output Impedance						
(differential)	Zout	_	100	_	Ω	
Termination Mismatch	TZm	_	_	5%		At 1 MHz
AC common mode voltage	TACcm	=	-	15	mVRMS	
Differential Return Loss	SDD22	-8	-	_	dB	.01 to 10 GHz
		(Note 3)	_	_	dB	10 to 15 GHz
Common Mode Return Loss	SCD22	-6	_	_	dB	.1 to 10 GHz
		(Note 4)	_	_	dB	10 to 15 GHz

TX Electrical	Symbol	Min.	Тур.	Max.	Unit	Notes
Transmitter Qsq	Tqsq	50	1	-	-	
Jitter (RMS)	TJrms	ı	ı	1.5	ps	(Note 5)
Jitter (PK-PK)	ТЈрр	1	1	8	ps	(Note 5)
Pre-Emphasis Control	TPE	1	17	_	dB	at 500 mVPPDIFF
De-Emphasis Control	TDE	-	17	-	dB	at 500 mVPPDIFF

Note 3: -8 dB + 16.6 dB/dec*log10(f/10 GHz)

Note 4: -6 dB + 16.6 dB/dec*log10(f/10 GHz)

Note 5: Agilent DCA-X with 50 GHz plug-in, 23-1 PRBS pattern and 500 waveforms using a precision time base trigger

RX Electrical	Symbol	Min.	Тур.	Max.	Unit	Notes
Baud Rate Tolerance	BRt	-100	-	100	PPM	
CML Input Voltage (Single						
Ended)	VinSE	100	-	800	mVpp	AC Coupled
CML Input Voltage	Vin DIEE	100		1600	ma\ / m m	A.C. Cavinland
(Differential)	VinDIFF	100	_	1600	mVpp	AC Coupled
Input Impedance (Differential)	Zin	_	100	_	Ω	
Termination Mismatch	RZm	_	ı	5	%	At 1 MHz
AC common mode voltage	RACcm	_	ı	25	mVRMS	
Differential Return Loss	SDD11	-12	-	_	dB	.01 to 2 GHz
		-8	-	_	dB	2 to 10 GHz
		(Note 3)	-	_	dB	10 to 15 GHz
Common Mode Return Loss	SCD11	-6	-	-	dB	.1 to 10 GHz
		(Note 4)	_	_	dB	10 to 15 GHz

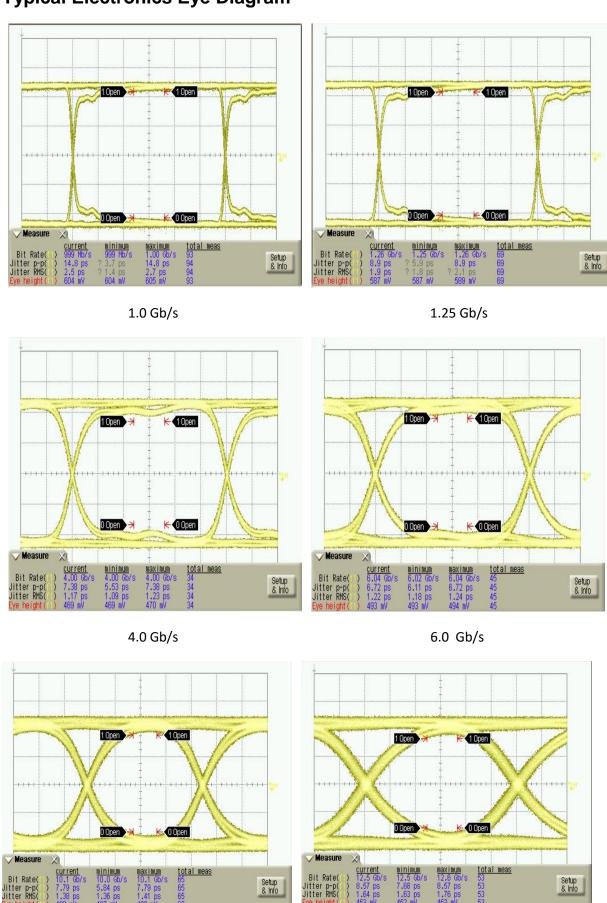
CDR Acquisition Lock Time – 300 mS

Clock - Input	Symbol	Min.	Тур.	Max.	Unit	Notes
Frequency	CFin	156,248,438	156,250,000	156,251,562	Hz	Square wave
Single Ended Voltage Swing	CVpp	0.4	-	1.2	V	
Input Impedance	CRin	49.5	50	50.5	Ohm	AC coupled
Rise/Fall Time	CitR, CitF	-	-	1	nS	20%-80%
Duty Cycle	CDC	40	ı	60	%	<1nS Tr/Tf
Random Jitter (RMS)	CRj	-	-	1	ps	12 kHz–20 MHz
Clock - Output	Symbol	Min.	Тур.	Max.	Unit	Notes
Programmable Divider of Line Rate	CPDLR	2	_	64	/N	Factors of 2
Single Ended Voltage Swing	CVoutSE	0	1	800	mVp	AC coupled
Squelch Voltage Output	CVsquelch	_	_	30	mVp	
Termination Mismatch	CZm	0	ı	5	%	At 1 MHz
Rise/Fall Time	COtR, COtF	20	_	_	ps	20-80%
Ouptut Return Loss	CS22	-8	-	-	dB	
Jitter (RMS)	CJrms	_	_	750	fs	(Note 5)
Jitter (PK-PK)	СЈрр	_	_	3.5	ps	(Note 5)

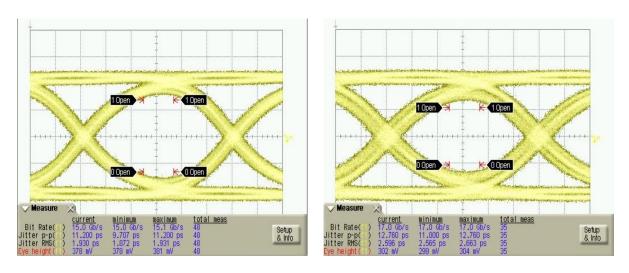
Note 5: Using Agilent DCA-X with 50 GHz plug-in. 500 waveforms using a precision time base trigger

Note 6: Terminate clock output if not used

Typical Electronics Eye Diagram

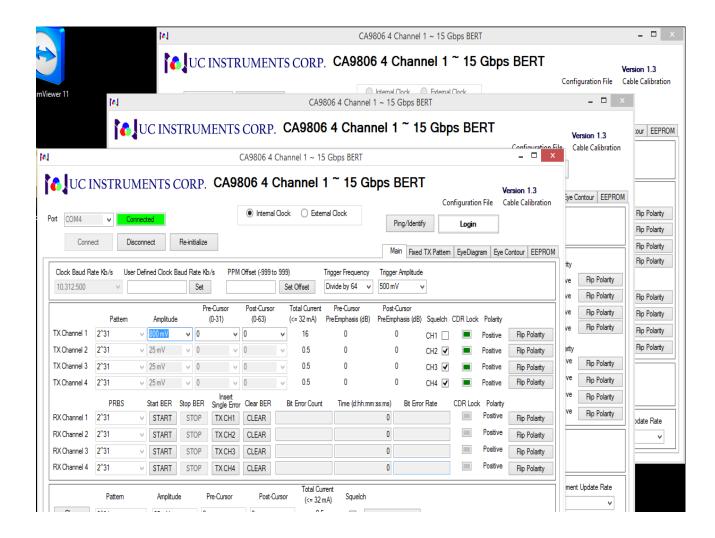


10.0 Gb/s 12.5 Gb/s

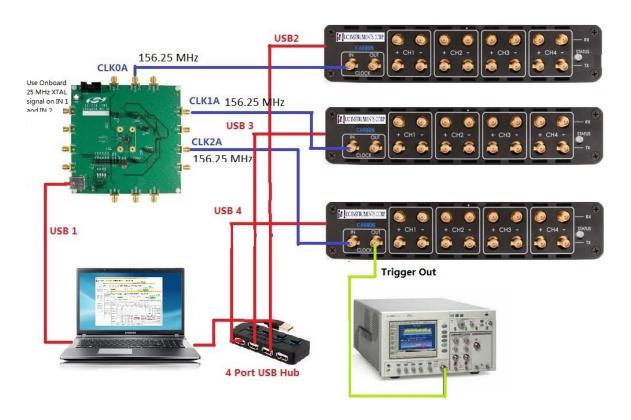


15.0 Gb/s 17.0 Gb/s

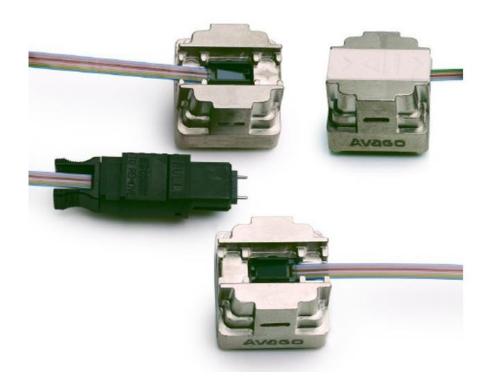
CA9806 Computer Control Interface



System Configuration;

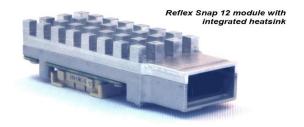


Typical Testing Application:



12 Channel 10 Gbps Parallel Fiber Optics Modules Testing

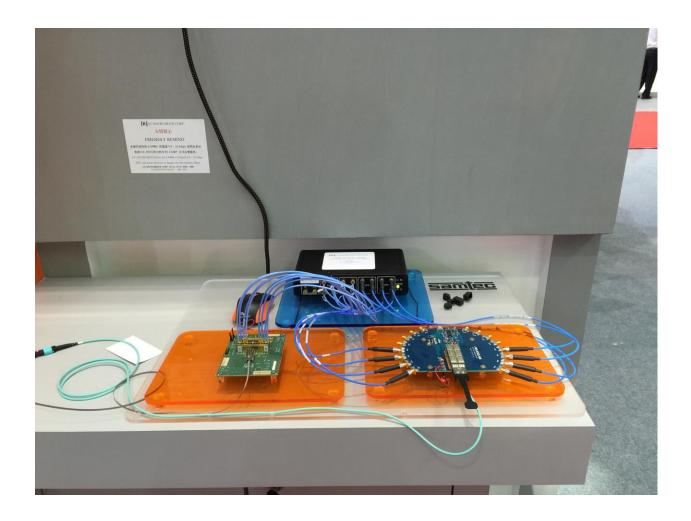




12 Channel 3.125G/3.5 G Data-Com Optical Transceiver Modules Testing



12 Channel PLCC 3.125 ~ 6.25 Gbps Parallel Optical Transceiver Testing



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